

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/815,464	MYERS ET AL.	
	Examiner	Art Unit	
	Tim Phan	3729	29/852

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
29	852	5/9/2007	TP
	832		
	842		
((chip or component or device) near (embedd\$3 or insert\$3)..			